

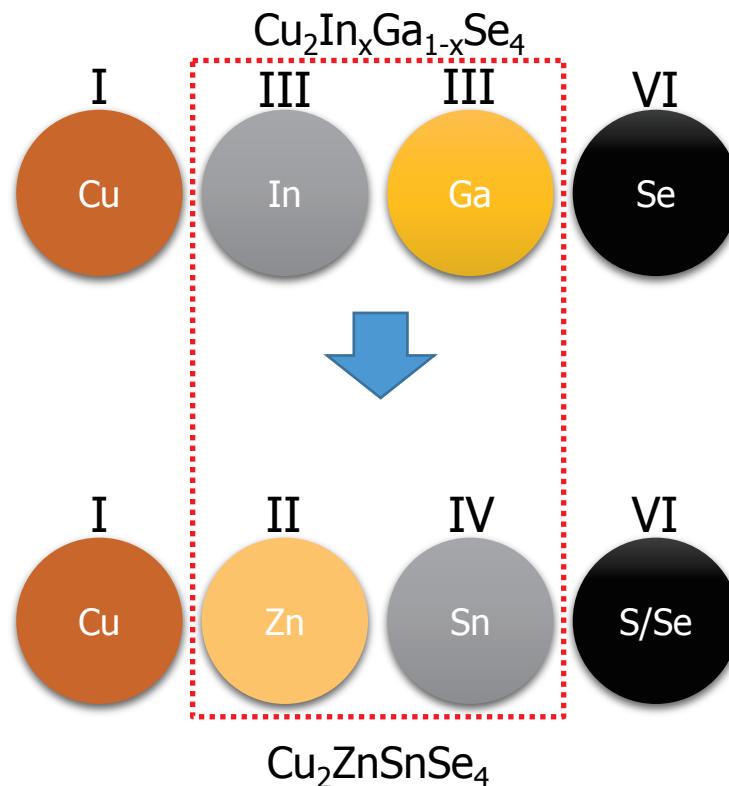
# Ge incorporated Cu<sub>2</sub>ZnSnSe<sub>4</sub> thin-film solar cells

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# Introduction – Kesterite solar cells

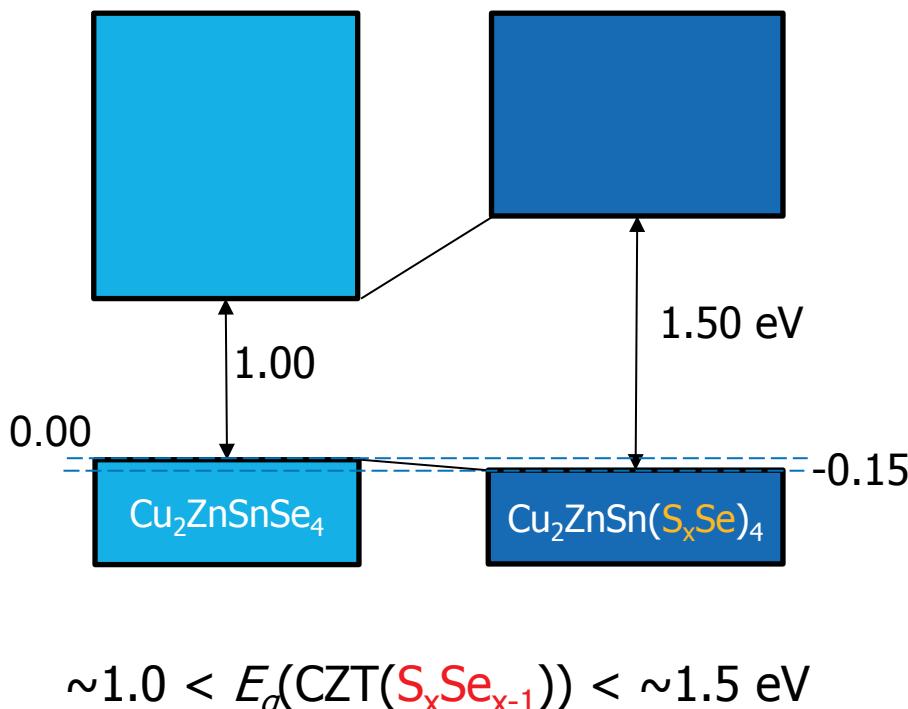
## CZT(S)Se



- In, Ga → Zn, Sn
- High absorption coefficient
  - $\alpha > 10^4 \text{ cm}^{-1}$
- Using the earth abundant materials
- Production cost down

# Introduction – Band gap tuning of kesterite thin films

## Band gap tuning with S incorporation



## Problems of S incorporation

- The control of  $\text{S}/(\text{S}+\text{Se})$  ratio is difficult due to the high volatility of the anionic components.
- Large  $V_{OC}$  deficit ( $E_g/q - V_{OC}$ ) with S incorporation<sup>1</sup>
  - CZTSe  $\approx 0.577$  mV  $\rightarrow$  CZTSSe  $\approx 0.647$ , (at champion cells respectively)
  - Ex) CIGSe  $\approx 0.5$
- Low  $FF^2$ 
  - Low  $V_{OC}$  and high ideality factor ( $A$ )
  - Secondary phase problems

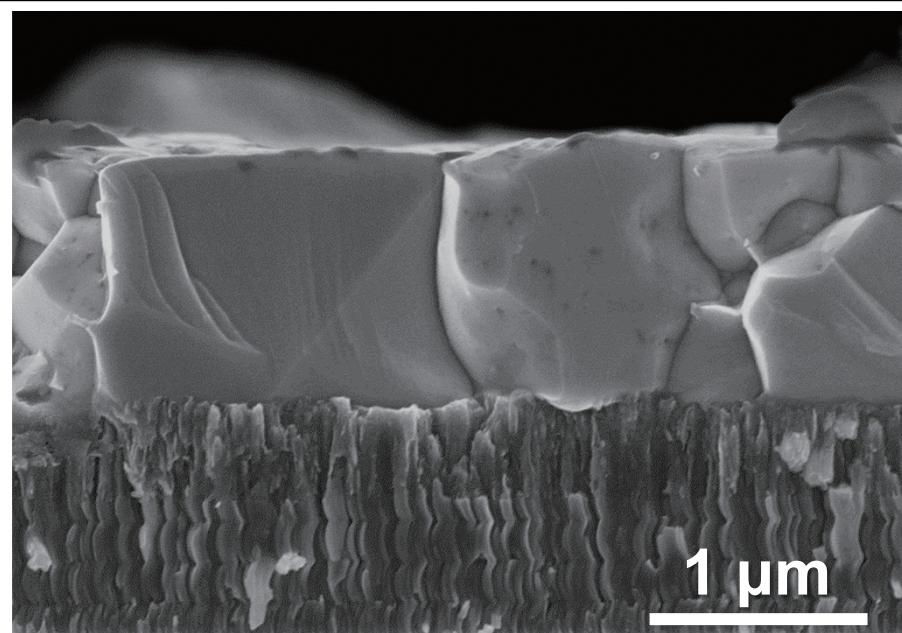
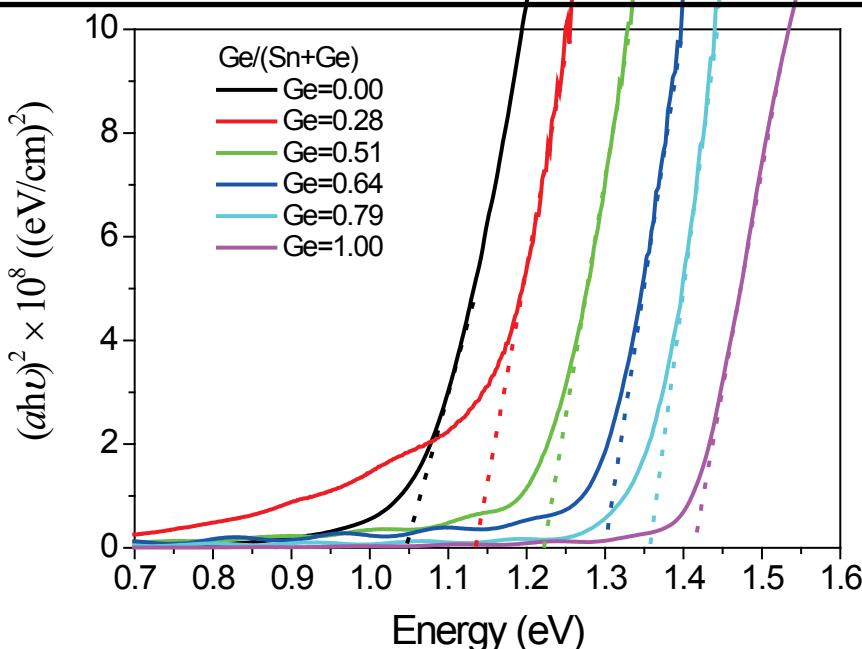
1. A. Polizzotti *et al.*, Energy & Environmental Science **6** (11), 3171-3182 (2013).

2. K. F. Tai *et al.*, Advanced Energy Materials **6** (3), (2016)

# Ge incorporated CZTSe (CZTGSe)

## CZTGSe

- Tunable band-gap using cationic element  
→  $\sim 1.0 < E_g(\text{CZTGSe}) < \sim 1.5 \text{ eV}$  controlled by Ge/(Sn+Ge) ratio.
- Reduced  $V_{OC}$  deficit
- Large grain growth caused by  $\text{GeSe}_2$  liquid phase



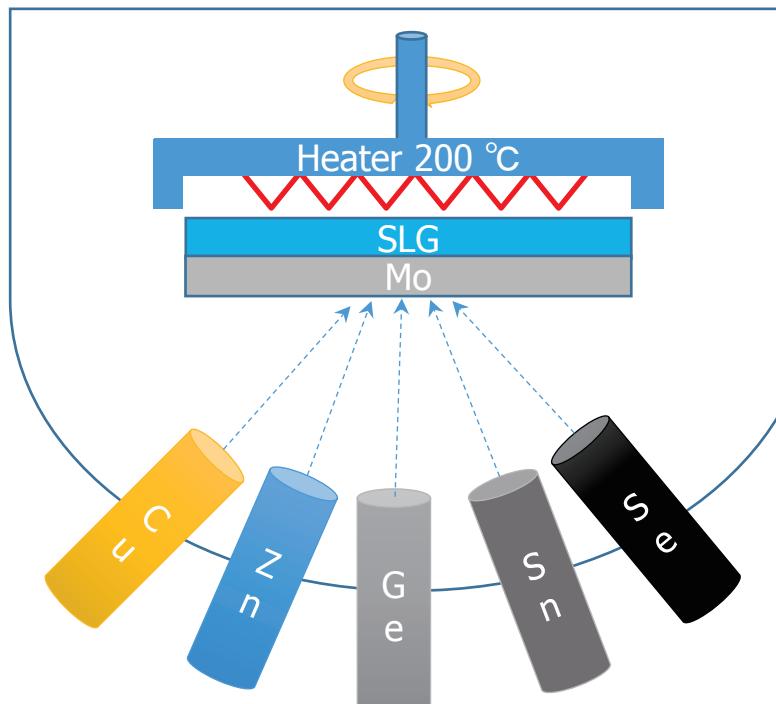
# I-V Results of Ge incorporated Cells

Cell	$Eff.$ (%)	$V_{OC}$ (V)	$J_{SC}$ (mA/cm <sup>2</sup> )	$FF$ (%)	$E_g$ (eV)	$E_g/q - V_{OC}$
CZTGSSe Perdue Univ. (2013) <sup>1</sup>	9.40	0.460	31.9	63.8	1.19	0.730
CZTGSe AIST (2015) <sup>2</sup>	10.03	0.543	29.5	62.7	1.19	0.647
CZTSe IREC(2015) <sup>3</sup>	10.60	0.473	34.3	65.1	1.03	0.550
CZTGSe Univ. of Washington (2016) <sup>4</sup>	11.00	0.583	33.6	55.9	1.30	0.717

1. C. J. Hages *et al.*, Progress in Photovoltaics: Research and Applications **23** (3), 376-384 (2013).
2. S. Kim *et al.*, Solar Energy Materials and Solar Cells **144**, 488-492 (2016).
3. S. Giraldo *et al.*, Advanced Energy Materials **5** (21), (2015).
4. A. D. Collord and H. W. Hillhouse, Chemistry of Materials **28** (7), 2067-2073 (2016).

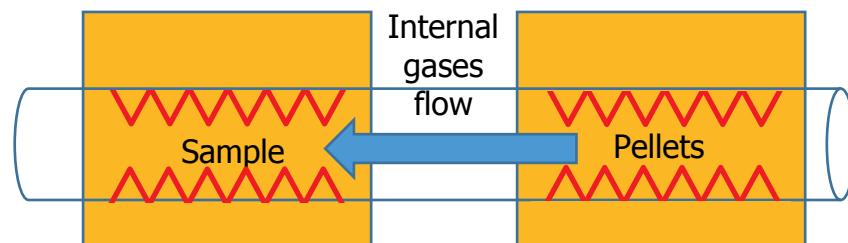
# Experimental Procedure

## Co-evaporation



As grown CZTGSe deposited by co-evaporation method.  
Composition Control

## Annealing

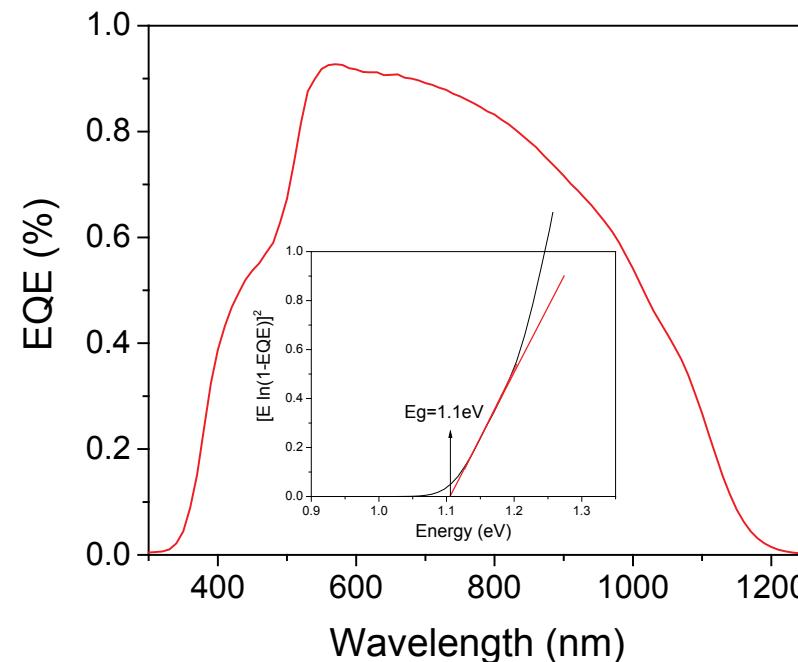
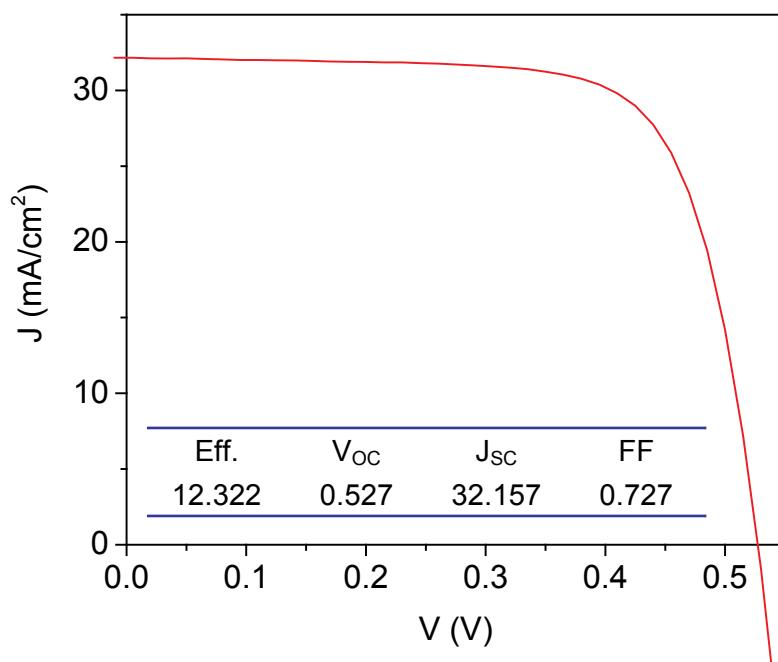


Annealing using two zone furnace  
Grain Growth

## CZTGSe solar cell structure



# New efficiency of Ge incorporated kesterite solar cell



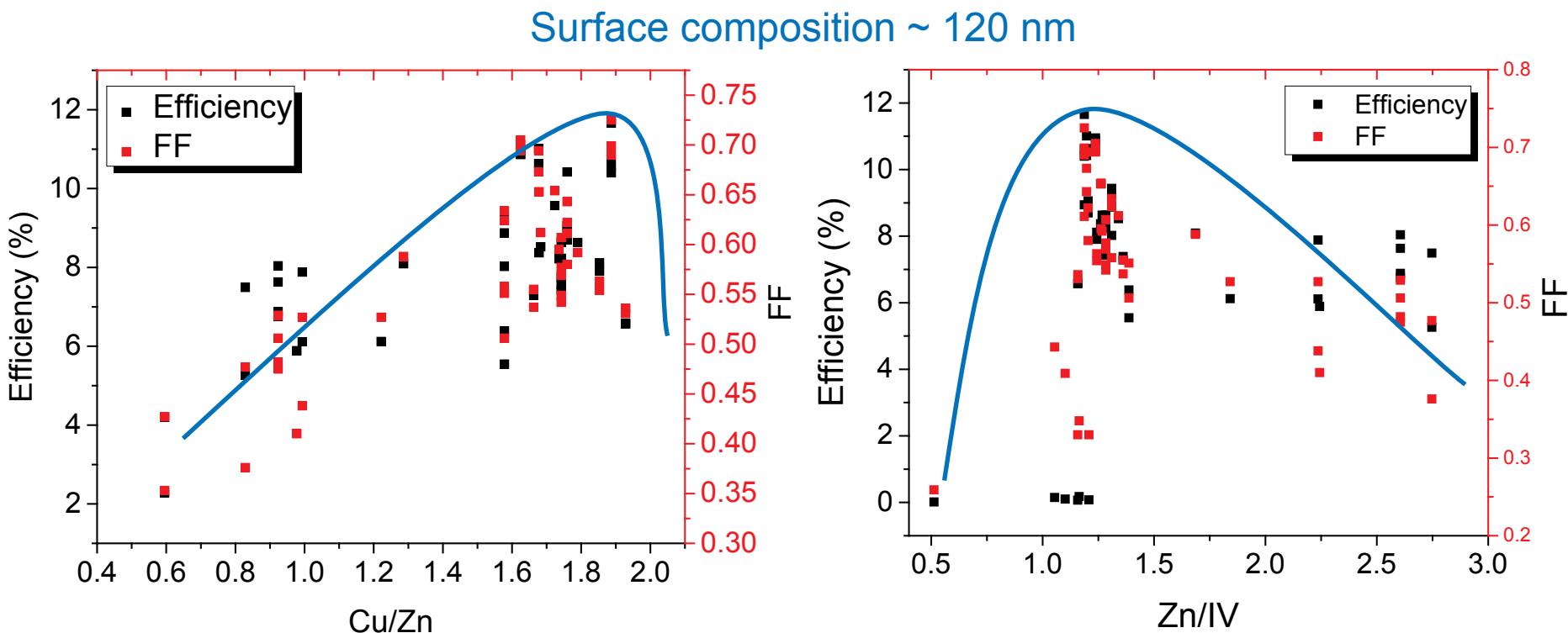
- The highest efficiency of Ge incorporated kesterite solar cell greater than 12%

# Device parameters

Cell	$Eff.$ (%)	$V_{oc}$ (V)	$J_{sc}$ (mA/cm <sup>2</sup> )	$FF$	$R_s$ (Ω·cm <sup>2</sup> )	$R_{sh}$ (Ω·cm <sup>2</sup> )	$A$	$J_o$ (A/cm <sup>2</sup> )	$E_g$ (eV)	$E_g/q - V_{oc}$
CZTSSe IBM (2013)	12.60	0.513	35.2	0.698	0.72	621	1.45	7.0E-8	1.13	0.617
CZTGSe AIST (2015)	10.03	0.543	29.5	0.627	0.20	694	2.49	6.3E-6	1.19	0.647
CZTGSe AIST (2016)	12.32	0.527	32.2	0.727	0.36	1111	1.47	3.6E-8	1.11	0.583

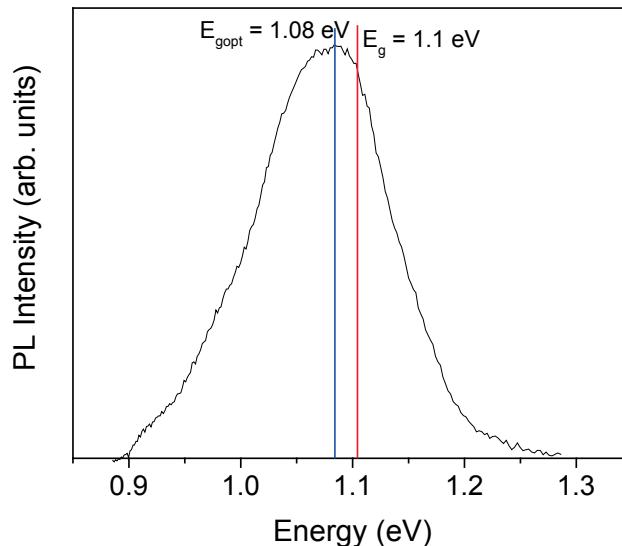
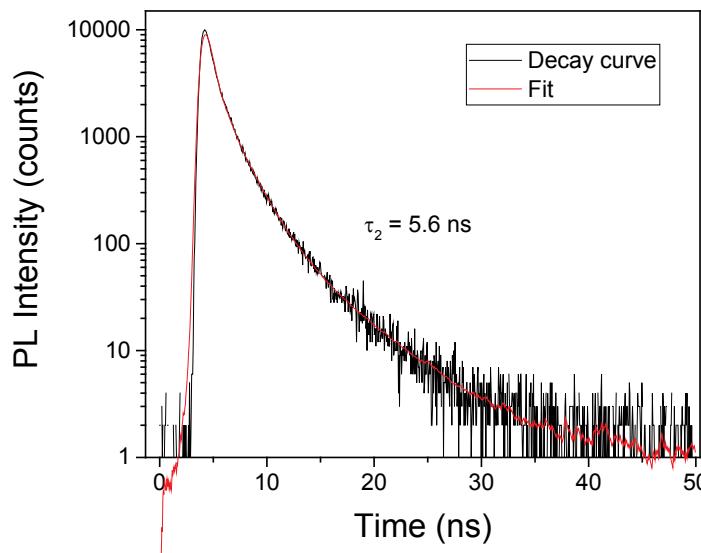
- Highly improved fill factor over 0.7
- Reduced device parameters –  $A$ ,  $J_o$  and  $V_{oc}$  deficit  
→ Improved junction quality and reduced carrier recombination in SCR

# Atomic ratio of CZTGSe thin films (EPMA)



- Efficiency shows similar tendency with *FF*.
- Optimized surface conditions are observed at Cu/Zn=1.9 and Zn/IV=1.2.

# Lifetime measurement by TRPL



Cell	Eff. (%)	Lifetime (ns)
CZTSSe IBM (2013)	12.60	6.7
CZTGSe AIST (2015)	10.03	2.5
CZTGSe AIST (2016)	12.32	5.6

- Improved carrier life time
- PL peak is closed to the band edge position ( $\approx 0.03$ )
  - it may be beneficial effect in reducing  $V_{OC}$  deficit

# Summary

- We demonstrate new results of Ge incorporated kesterite thin-film solar cell.
  - High efficiency greater than 12%
  - Large improvement in  $FF$  over 0.7
  - Improved junction quality and reduced carrier recombination in SCR
    - $A$ ,  $J_0$  and  $V_{OC}$  deficit
  - Increased carrier life time

**Thank you for your  
attention!**